4-Line To 10-Line Decoders (1-of-10)

LS42 LS43 LS44

FEATURES

- All Outputs Are High for Invalid Input Conditions
- Also for Application as
  - 4-Line to 16-Line Decoders
  - 3-Line to 8-Line Decoders

DESCRIPTION

These monolithic decimal decoders consist of eight inverters and ten four-input NAND gates. The inverters are connected in pairs to make BCD input data available for decoding by the NAND gates. Full decoding of valid input logic ensures that all outputs remain off for all invalid input conditions.

The LS42 BCD-to-decimal decoders, the LS43 excess-3-to-decimal decoders, and the LS44 excess-3-gray-to-decimal decoders feature inputs and outputs that are compatible for use with most TTL and other saturated low-level logic circuits.

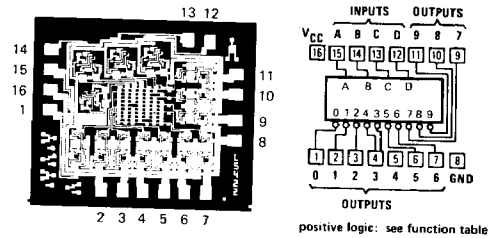
54LS circuits are characterized for operation over the full military temperature range of −55°C to 125°C; 74LS circuits are characterized for operation from 0°C to 70°C.

NO.	LS42 BCD INPUT				LS43 EXCESS 3 INPUT				LS44 EXCESS 3-GRAY INPUT				ALL TYPES DECIMAL OUTPUT									
	D	C	B	A	D	C	B	A	D	C	B	A	0	1	2	3	4	5	6	7	8	9
0	L	L	L	L	L	L	H	H	L	L	H	L	L	H	H	H	H	H	H	H	H	H
1	L	L	L	H	L	H	L	L	L	H	H	L	H	L	H	H	H	H	H	H	H	H
2	L	L	H	L	L	H	L	H	L	H	H	H	H	H	L	H	H	H	H	H	H	H
3	L	L	H	H	L	H	H	L	L	H	L	H	H	H	H	L	H	H	H	H	H	H
4	L	H	L	L	L	H	H	H	L	H	L	L	H	H	H	H	L	H	H	H	H	H
5	L	H	L	H	H	L	L	L	H	H	L	L	H	H	H	H	H	L	H	H	H	H
6	L	H	H	L	H	L	L	H	H	H	L	H	H	H	H	H	H	H	L	H	H	H
7	L	H	H	H	H	L	H	L	H	H	H	H	H	H	H	H	H	H	H	L	H	H
8	H	L	L	L	H	L	H	H	H	H	H	L	H	H	H	H	H	H	H	H	L	H
9	H	L	L	H	H	H	L	L	H	H	H	L	H	H	H	H	H	H	H	H	H	L
INVALID	H	L	H	L	H	H	L	H	H	L	H	H	H	H	H	H	H	H	H	H	H	H
	H	L	H	H	H	H	H	L	H	L	L	H	H	H	H	H	H	H	H	H	H	H
	H	H	L	L	H	H	H	H	H	L	L	L	H	H	H	H	H	H	H	H	H	H
	H	H	L	H	L	L	L	L	L	L	L	L	H	H	H	H	H	H	H	H	H	H
	H	H	H	L	L	L	L	H	L	L	L	H	H	H	H	H	H	H	H	H	H	H
	H	H	H	H	L	L	H	L	L	L	H	H	H	H	H	H	H	H	H	H	H	H

H = high level, L = low level

PIN-OUT DIAGRAM

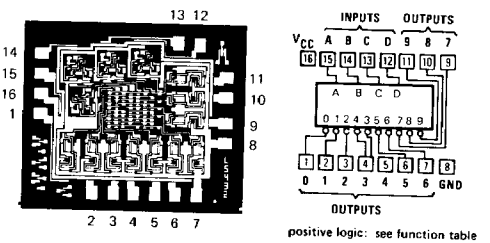
LS42
BCD-TO-DECIMAL DECODER



positive logic: see function table

Die Size .077 x .065

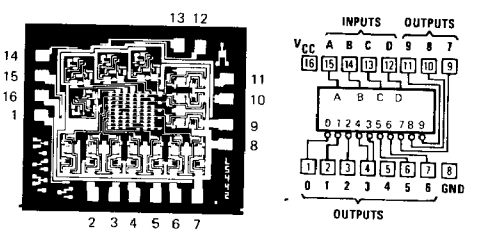
LS43
EXCESS-3-TO-DECIMAL DECODER



positive logic: see function table

Die Size .077 x .065

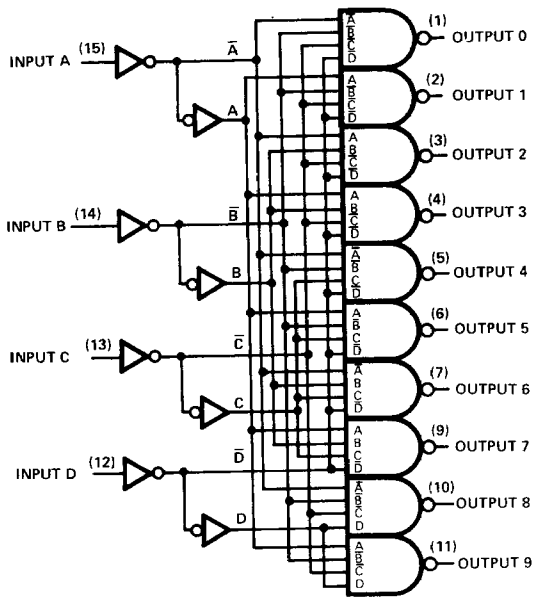
LS44
EXCESS-3-GRAY-TO-DECIMAL DECODER



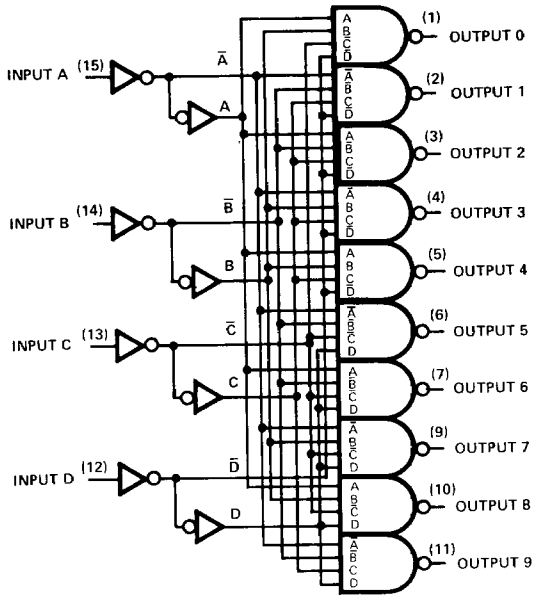
positive logic: see function table

Die Size .077 x .065

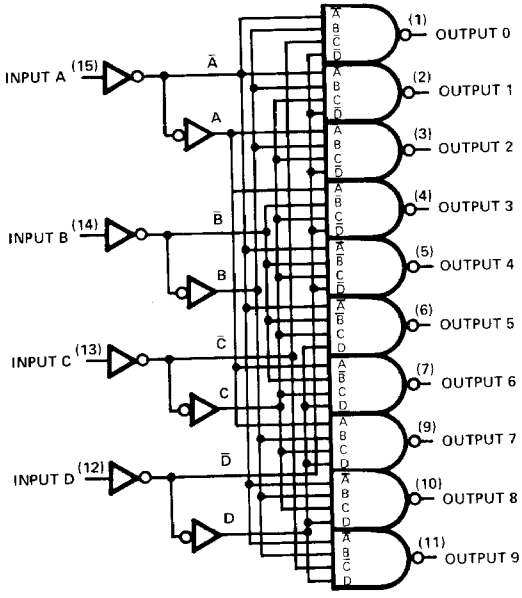
LOGIC DIAGRAMS



LS42
BCD-TO-DECIMAL DECODERS



LS43
EXCESS-3-TO-DECIMAL DECODERS



LS44
EXCESS-3-GRAY-TO-DECIMAL-DECODERS

Recommended Operating Conditions

	9LS/54LS			9LS/74LS			Unit
	Min	Nom	Max	Min	Nom	Max	
Supply voltage, V_{CC}	4.5	5	5.5	4.75	5	5.25	V
High level output current, I_{OH}			-400			-400	μA
Low-level output current, I_{OL}			4			8	mA
Operating free-air temperature, T_A	-55		125	0		70	°C

Electrical Characteristics Over Recommended Free-Air Temperature Range (Unless Otherwise Noted)

Parameter	Test Conditions*		9LS/54LS			9LS/74LS			Unit
			Min	Typ**	Max	Min	Typ**	Max	
V_{IH}			2			2			V
V_{IL}					0.7			0.8	V
V_I	V_{CC}=MIN, I_I=-18mA				-1.5			-1.5	V
V_{OH}	V_{CC}=MIN, V_{IH}=2V, V_{IL}=V_{IL}max I_{OH}=-400μA		2.5	3.5		2.7	3.5		V
V_{OL}	V_{CC}=MIN, V_{IH}=2V, V_{IL}=V_{IL}max	I_{OL}=4mA		0.25	0.4		0.25	0.4	V
		I_{OL}=8mA					0.35	0.5	
I_I	V_{CC}=MAX, V_I=7V				0.1			0.1	mA
I_{IH}	V_{CC}=MAX, V_I=2.7V				20			20	μA
I_{IL}	V_{CC}=MAX, V_I=0.4V				-0.4			-0.4	mA
I_{OS}†	V_{CC}=MAX		-15		-100	-15		-100	mA
I_{CC}††	V_{CC}=MAX,			7	13		7	13	mA

*For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable device type.
**All typical values are at V_{CC} = 5V, T_A = 25°C.
†Not more than one output should be shorted at a time.
††I_{CC} is measured with all outputs open and inputs grounded.

Switching Characteristics, V_{CC} = 5V Over Recommended Free-Air Temperature Range

Parameter	From (Input)	To (Output)	-55°C			+25°C			+125°C			Units
			Min.	Typ.	Max.	Min.	Typ.	Max.	Min.	Typ.	Max.	
Test Conditions: C_L = 15pF, R_L = 2kΩ (See Fig. A, page 2-174)												
t_{PHL}	A,B,C or D	Any output 2 gate delay		15	26		14	25		15	26	ns
t_{PHL}	A,B,C or D	Any Output 3 gate delay		17	31		17	30		18	31	ns
t_{PLH}	A,B,C or D	Any output 2 gate delay		11	27		10	25		11	26	ns
t_{PLH}	A,B,C or D	Any output 3 gate delay		22	35		17	30		20	34	ns
Test Conditions: C_L = 50pF, R_L = 2kΩ (See Fig. A, page 2-174)												
t_{PHL}	A,B,C or D	Any Output 2 gate delay		18	32		18	31		19	33	ns
t_{PHL}	A,B,C or D	Any Output 3 gate delay		21	35		22	35		23	36	ns
t_{PHL}	A,B,C or D	Any Output 2 gate delay		21	33		20	32		21	33	ns
t_{PLH}	A,B,C or D	Any Output 3 gate delay		29	36		25	38		28	40	ns

Note: AC specification shown under -55°C and +125°C are for 9LS devices only. All 50pF specifications are for 9LS only.